



# HIGH VOLTAGE FAST-SWITCHING NPN POWER TRANSISTOR

- n HIGH VOLTAGE CAPABILITY
- n LOW SPREAD OF DYNAMIC PARAMETERS
- n MINIMUM LOT-TO-LOT SPREAD FOR RELIABLE OPERATION
- n VERY HIGH SWITCHING SPEED

#### **APPLICATIONS**

n COMPACT FLUORESCENT LAMPS (CFLS)

### **DESCRIPTION**

The device is manufactured using High Voltage Multi Epitaxial Planar technology for high switching speeds and high voltage capability. It uses a Cellular Emitter structure with planar edge termination to enhance switching speeds while maintaining the wide RBSOA.

The STBV series is designed for use in Compact Fluorescent Lamps.

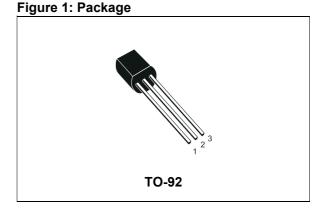
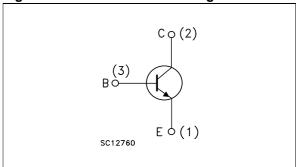


Figure 2: Internal Schematic Diagram



**Table 1: Order Codes** 

Part Number	Part Number Marking		Packaging
STBV32	BV32	TO-92	Bulk
STBV32-AP	BV32	TO-92	Ammopack

**Table 2: Absolute Maximum Ratings** 

Symbol	Parameter	Value	Unit
V <sub>CES</sub>	Collector-Emitter Voltage (V <sub>BE</sub> = 0)	700	V
V <sub>CEO</sub>	Collector-Emitter Voltage (I <sub>B</sub> = 0)	400	V
V <sub>EBO</sub>	Emitter-Base Voltage ( $I_C = 0$ , $I_B = 0.5 A$ , $t_p < 10 ms$ )	V <sub>(BR)EBO</sub>	V
	Collector Current	1.5	А
I <sub>C</sub>	(f $\geq$ 100 Hz, duty-cycle $\leq$ 50 %, T <sub>C</sub> = 25 °C)		
I <sub>CM</sub>	Collector Peak Current (t <sub>p</sub> < 5ms)	3	А
I <sub>B</sub>	Base Current	0.5	А
I <sub>BM</sub>	Base Peak Current (t <sub>p</sub> < 5ms)	1.5	А
P <sub>tot</sub>	Total Dissipation at T <sub>C</sub> = 25 °C	1.5	W

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Symbol	Parameter	Value	Unit
T <sub>stg</sub>	Storage Temperature	-65 to 150	°C
T <sub>J</sub>	Max. Operating Junction Temperature	150	°C

### **Table 3: Thermal Data**

R <sub>thj-case</sub>	Thermal Resistance Junction-case	Max	83.3	°C/W
R <sub>thj-amb</sub>	Thermal Resistance Junction-Ambient	Max	112	°C/W

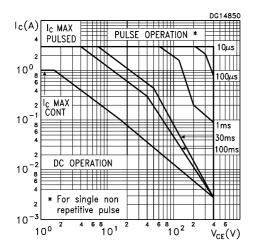
# Table 4: Electrical Characteristics (T<sub>case</sub> = 25 °C unless otherwise specified)

Symbol	Parameter	Test Co	nditions	Min.	Тур.	Max.	Unit
I <sub>CEV</sub>	Collector Cut-off Current	V <sub>CE</sub> = 700 V				1	mA
	(V <sub>BE</sub> = -1.5 V)	V <sub>CE</sub> = 700 V	T <sub>j</sub> =125 °C			5	mA
V <sub>(BR)EBO</sub>	Emitter-Base Breakdown Voltage	I <sub>E</sub> = 10 mA		9		18	V
	$(I_C = 0)$						
V <sub>CEO(sus)</sub> *	Collector-Emitter Sustaining Voltage	I <sub>C</sub> = 10 mA		400			V
	(I <sub>B</sub> = 0)						
V <sub>CE(sat)</sub> *	Collector-Emitter	I <sub>C</sub> = 0.5 A	I <sub>B</sub> = 100 mA			0.5	V
	Saturation Voltage	I <sub>C</sub> = 1 A	$I_{B} = 250 \text{ mA}$			1	V
		I <sub>C</sub> = 1.5 A	I <sub>B</sub> = 500 mA			1.5	V
V <sub>BE(sat)</sub> *	Base-Emitter Saturation	I <sub>C</sub> = 0.5 A	I <sub>B</sub> = 100 mA			1.0	V
	Voltage	I <sub>C</sub> = 1 A	$I_{B} = 250 \text{ mA}$			1.2	V
h <sub>FE</sub>	DC Current Gain	I <sub>C</sub> = 0.5 A	V <sub>CE</sub> = 2 V	8		35	
		I <sub>C</sub> = 1 A	$V_{CE} = 2 V$	5		25	
	RESISTIVE LOAD	I <sub>C</sub> = 1 A	V <sub>CC</sub> = 125 V				
$t_r$	Rise Time	$I_{B1} = -I_{B2} = 200 \text{ mA}$	t <sub>p</sub> = 25 μs			1	μs
$t_s$	Storage Time	(see figure 12)	·			4	μs
$t_f$	Fall Time					0.7	μs
	INDUCTIVE LOAD	I <sub>C</sub> = 1 A	V <sub>clamp</sub> = 300 V				
$t_s$	Storage Time	I <sub>B1</sub> = 200 mA	$V_{BE(off)} = -5V$		8.0		μs
		L = 50 mH	$R_{BB} = 0$				
	address 200 vs. dut. saud	(see figure 13)					

<sup>\*</sup> Pulsed: Pulsed duration = 300 μs, duty cycle ≤ 1.5 %.

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Figure 3: Safe Operating Area



**Figure 4: Output Characteristics** 

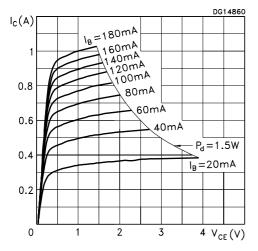


Figure 5: Base-Emitter Saturation Voltage

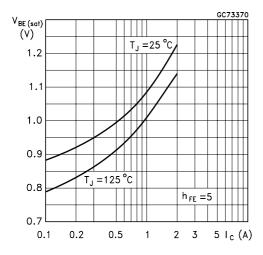


Figure 6: Derating Curve

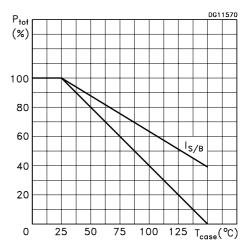


Figure 7: Collector-Emitter Saturation Voltage

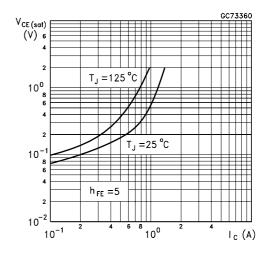


Figure 8: DC Current Gain

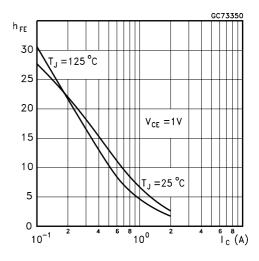


Figure 9: DC Current Gain

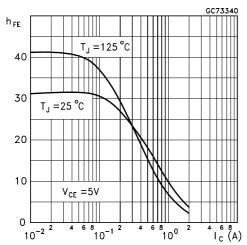


Figure 10: Reverse Biased Operating Area

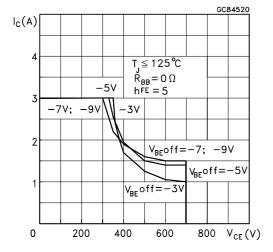
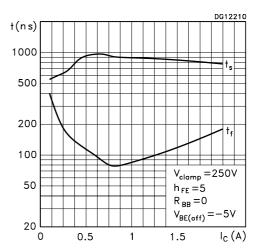
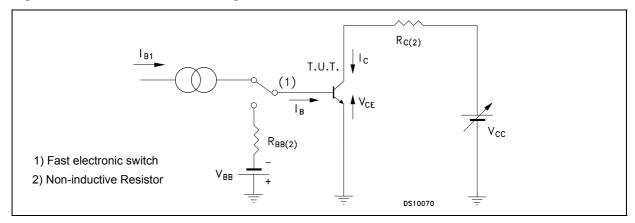


Figure 11: Inductive Load Switching Times

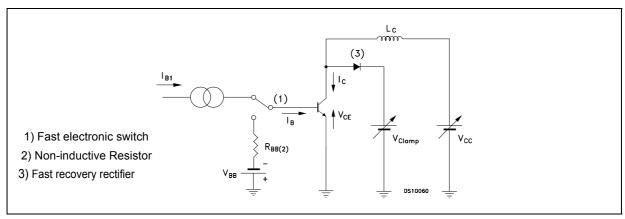


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Figure 12: Resistive Load Switching Test Circuit

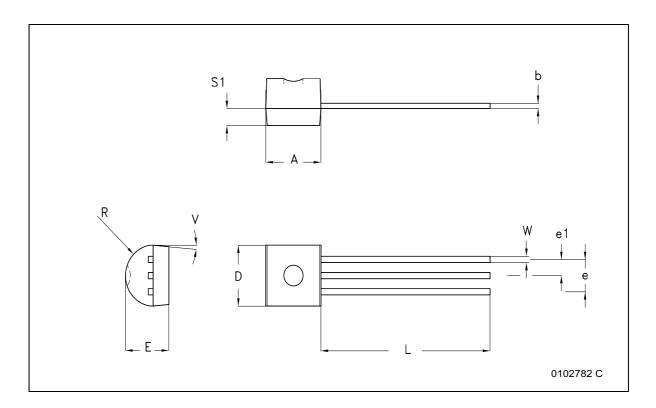


**Table 13: Inductive Load Switching Test Circuit** 



### **TO-92 BULK SHIPMENT MECHANICAL DATA**

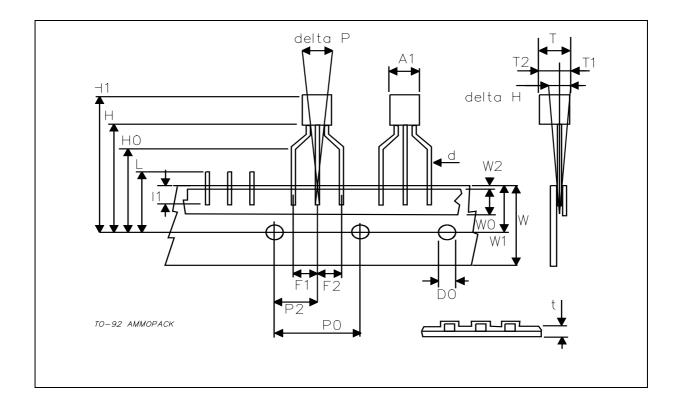
DIM.	mm.					
DIWI.	MIN.	ТҮР	MAX.			
А	4.32		4.95			
b	0.36		0.51			
D	4.45		4.95			
E	3.30		3.94			
е	2.41		2.67			
e1	1.14		1.40			
L	12.70		15.49			
R	2.16		2.41			
S1	0.92		1.52			
W	0.41		0.56			
V		5 <sup>O</sup>				



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## TO-92 AMMOPACK SHIPMENT (Suffix"-AP") MECHANICAL DATA

DIM.	mm.				
	MIN.	TYP	MAX.		
A1			4.80		
Т			3.80		
T1			1.60		
T2			2.30		
d			0.48		
P0	12.50	12.70	12.90		
P2	5.65	6.35	7.05		
F1,F2	2.44	2.54	2.94		
delta H	-2.00		2.00		
W	17.50	18.00	19.00		
W0	5.70	6.00	6.30		
W1	8.50	9.00	9.25		
W2			0.50		
Н	18.50		20.50		
H0	15.50	16.00	16.50		
H1			25.00		
D0	3.80	4.00	4.20		
t			0.90		
L			11.00		
I1	3.00				
delta P	-1.00		1.00		



## STBV32

## Figure 1: Revision History

Version	Release Date	Change Designator
01-Dec-2002	1	First Release.
27-Apr-2005	1	Total dissipation value has been modified.

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